



UTT10NN03

Power MOSFET

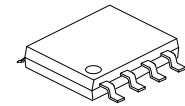
8A, 30V DUAL N-CHANNEL ENHANCEMENT MODE POWER MOSFET

DESCRIPTION

The UTC **UTT10NN03** is a N-channel Power MOSFET, it uses UTC's advanced technology to provide the customers with low $R_{DS(on)}$ characteristic by high cell density trench technology.

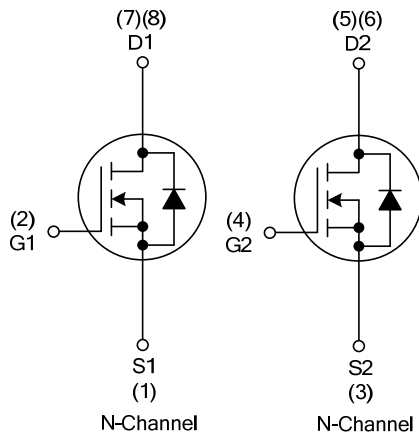
FEATURES

- * $R_{DS(ON)} < 20\text{ m}\Omega$ @ $V_{GS}=10\text{V}$, $I_D=9.0\text{A}$
- * $R_{DS(ON)} < 30\text{ m}\Omega$ @ $V_{GS}=4.5\text{V}$, $I_D=7.0\text{A}$
- * Fast Switching Speed
- * Simple Drive Requirement



SOP-8

SYMBOL



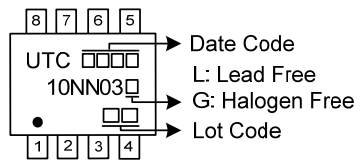
ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
UTT10NN03L-S08-R	UTT10NN03G-S08-R	SOP-8	S1	G1	S2	G2	D2	D2	D1	D1	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UTT10NN03G-S08-R		(1) Packing Type	(1) R: Tape Reel
		(2) Package Type	(2) S08: SOP-8
		(3) Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^{\circ}\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	V
Drain Current	Continuous	I_D	10	A
	Pulsed (Note 2)	I_{DM}	30	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	71	mJ
Power Dissipation		P_D	1.5	W
Junction Temperature		T_J	+150	$^{\circ}\text{C}$
Storage Temperature		T_{STG}	-55 ~ +150	$^{\circ}\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. $L=0.1\text{mH}$, $I_{AS}=37.7\text{A}$, $V_{DD}=25\text{V}$, $R_G=25\Omega$, Starting $T_J=25^{\circ}\text{C}$.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	83	$^{\circ}\text{C/W}$
Junction to Case	θ_{JA}	14.5	$^{\circ}\text{C/W}$

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

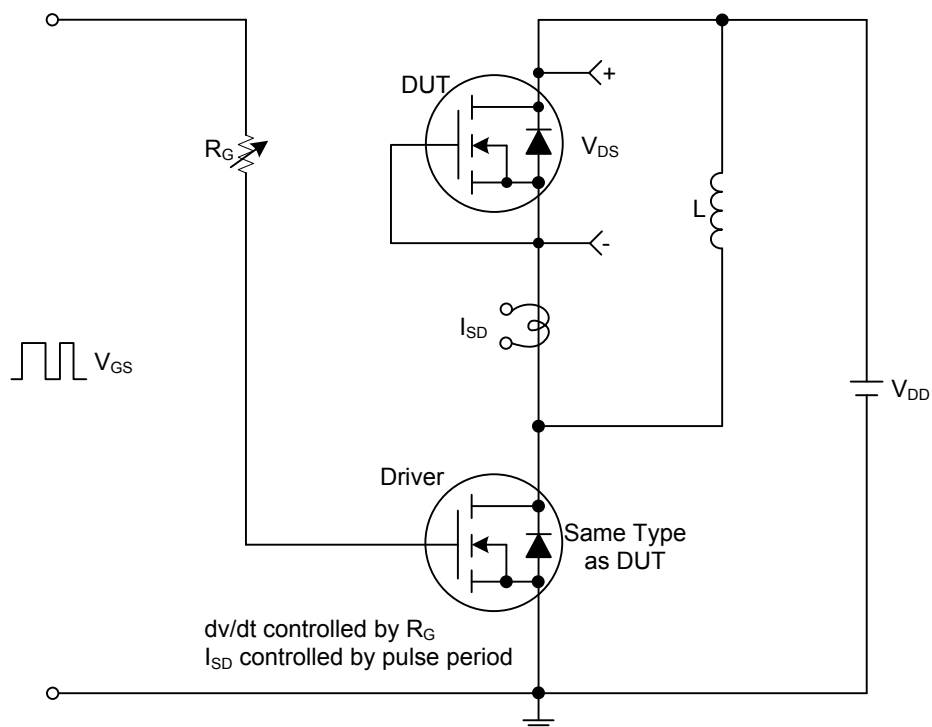
■ ELECTRICAL CHARACTERISTICS ($T_J=25^{\circ}\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} =0V, I _D =250μA	30			V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =30V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	Forward	I _{GSS}	V _{DS} =0V, V _{GS} =20V			100	nA
	Reverse		V _{DS} =0V, V _{GS} =-20V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	V _{DS} =V _{GS} , I _D =250μA	1.0		3.0	V
Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =9.0A			20	mΩ
			V _{GS} =4.5V, I _D =7.0A			30	mΩ
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}	V _{DS} =10V, V _{GS} =0V, f=1.0MHz		1080		pF
Output Capacitance		C _{OSS}			520		pF
Reverse Transfer Capacitance		C _{RSS}			210		pF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q _G	V _{DS} =15V, V _{GS} =5V, I _D =1A (Note 1, 2)		44.4		nC
Gate-Source Charge		Q _{GS}			8		nC
Gate-Drain Charge		Q _{GD}			15.4		nC
Turn-ON Delay Time (Note 1)		t _{D(ON)}	V _{DD} =15V, V _{GS} =10V, I _D =1A, R _G =6Ω, R _L =15Ω(Note 1, 2)		28		ns
Turn-ON Rise Time		t _R			34		ns
Turn-OFF Delay Time		t _{D(OFF)}			220		ns
Turn-OFF Fall Time		t _F			124		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS							
Maximum Body-Diode Continuous Current		I _S				10	A
Maximum Body-Diode Pulsed Current		I _{SM}				30	A
Drain-Source Diode Forward Voltage (Note 1)		V _{SD}	I _S =10A, V _{GS} =0V			0.8	V

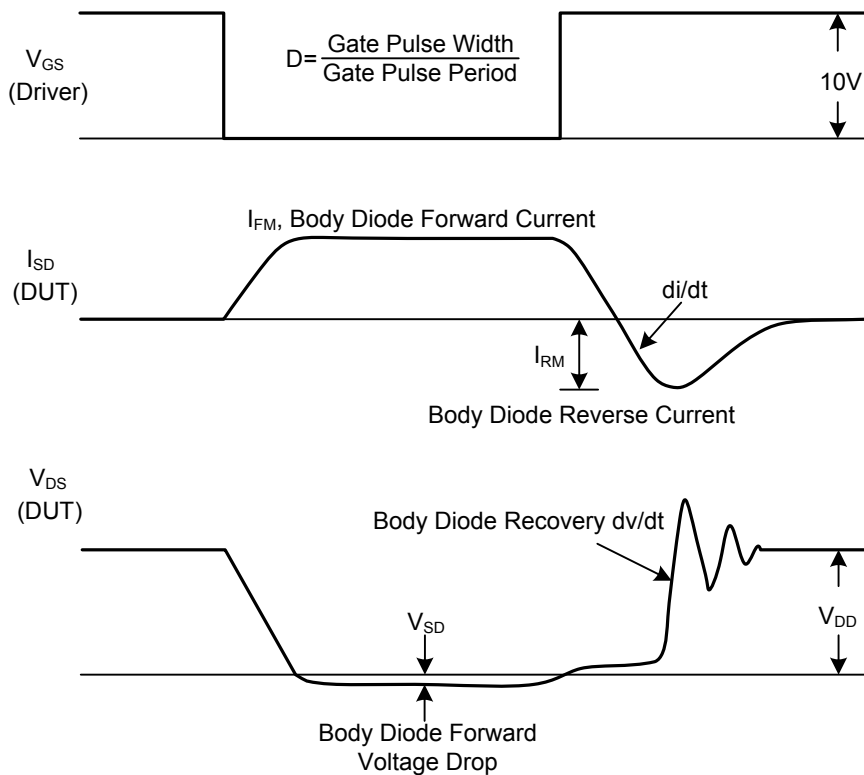
Notes: 1. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

2. Essentially independent of operating temperature.

■ TEST CIRCUITS AND WAVEFORMS



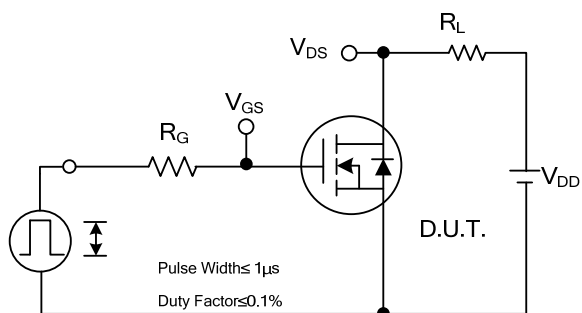
Peak Diode Recovery dv/dt Test Circuit



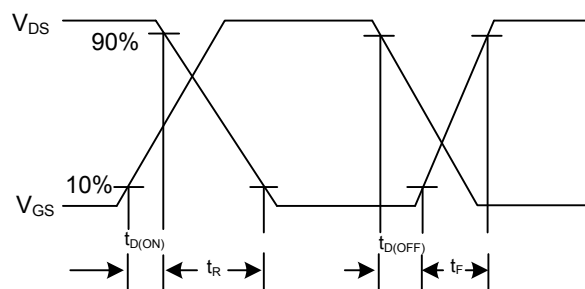
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

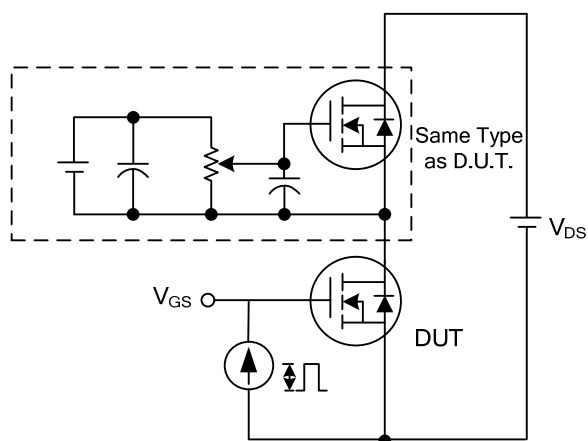
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



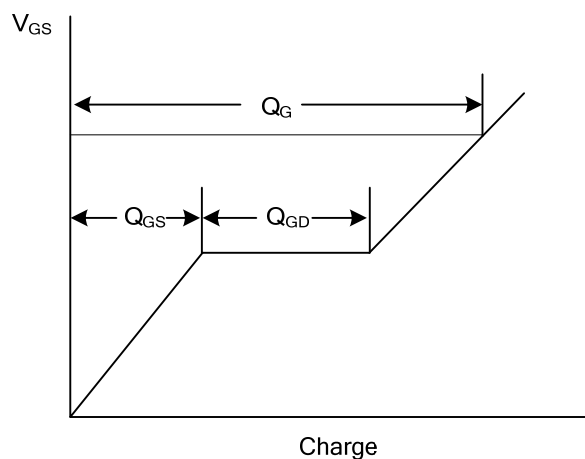
Switching Test Circuit



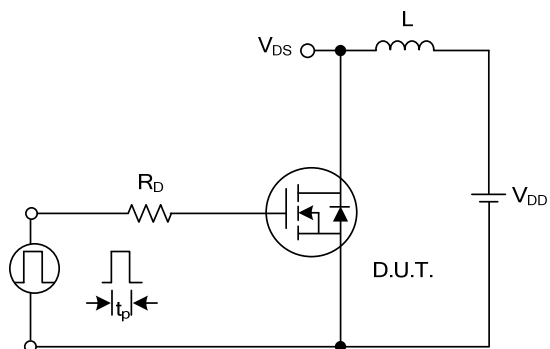
Switching Waveforms



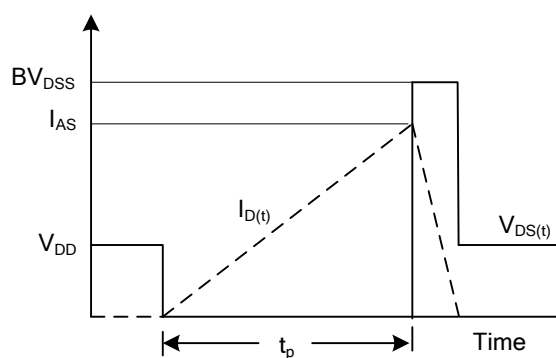
Gate Charge Test Circuit



Gate Charge Waveform

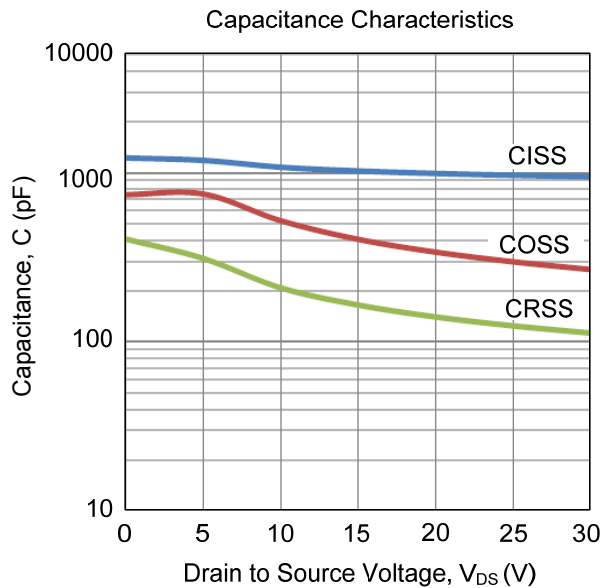


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ TYPICAL CHARACTERISTICS



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